Yixin

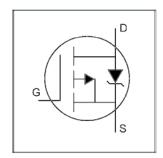
IRFR9120NPbF

- Ultra Low On-Resistance
- P-Channel
- Surface Mount (IRFR9120N)
- Straight Lead (IRFU9120N)
- · Advanced Process Technology
- Fast Switching
- · Fully Avalanche Rated
- · Lead-Free

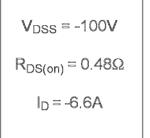
Description

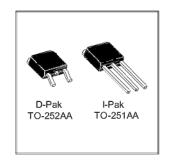
Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D-Pak is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 watts are possible in typical surface mount applications.



Power MOSFET





Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ -10V	-6.6	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ -10V	-4.2	A
I _{DM}	Pulsed Drain Current ①	-26	
P _D @T _C = 25°C	Power Dissipation	40	W
	Linear Derating Factor	0.32	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy®	100	mJ
l _{AR}	Avalanche Current®	-6.6	A
E _{AR}	Repetitive Avalanche Energy	4.0	mJ
dv/dt	Peak Diode Recovery dv/dt 3	-5.0	V/ns
TJ	Operating Junction and	-55 to + 150	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
R ₀ JC	Junction-to-Case		3.1	
R _{eJA}	Junction-to-Ambient (PCB mount)**		50	°C/W
R _{eJA}	Junction-to-Ambient		110	

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Parameter	Min.	Тур.	Max.	Units	Conditions
Drain-to-Source Breakdown Voltage	-100			V	$V_{GS} = 0V, I_{D} = -250\mu A$
Breakdown Voltage Temp. Coefficient		-0.11		V/°C	Reference to 25°C, I _D = -1mA
Static Drain-to-Source On-Resistance			0.48	Ω	V _{GS} = -10V, I _D = -3.9A ⊕
Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}$, $I_D = -250\mu A$
Forward Transconductance	1.4			S	$V_{DS} = -50V, I_{D} = -4.0A$ ©
Drain-to-Source Leakage Current			-25		V _{DS} = -100V, V _{GS} = 0V
Brain to obdice Edanage Garrent			-250	μΛ	V_{DS} = -80V, V_{GS} = 0V, T_{J} = 150°C
Gate-to-Source Forward Leakage			100	nΛ	V _{GS} = 20V
Gate-to-Source Reverse Leakage			-100] "[V _{GS} = -20V
Total Gate Charge			27		I _D = -4.0A
Gate-to-Source Charge			5.0	nC	$V_{DS} = -80V$
Gate-to-Drain ("Miller") Charge			15	1	V _{GS} = -10V, See Fig. 6 and 13 ⊕ ©
Turn-On Delay Time		14			V _{DD} = -50V
Rise Time		47]	$I_D = -4.0A$
Turn-Off Delay Time		28		ns	$R_G = 12 \Omega$
FallTime		31]	R _D =12 Ω, See Fig. 10 ⊕ ⑥
Internal Drain Inductance		4.5			Between lead,
memai Brain madolando		1.0		nH	6mm (0.25in.)
Internal Source Inductance		7.5		""	from package
					and center of die contact® s
Input Capacitance		350			V _{GS} = 0V
Output Capacitance		110		pF	$V_{DS} = -25V$
Reverse Transfer Capacitance		70			f = 1.0MHz, See Fig. 5©
	Drain-to-Source Breakdown Voltage Breakdown Voltage Temp. Coefficient Static Drain-to-Source On-Resistance Gate Threshold Voltage Forward Transconductance Drain-to-Source Leakage Current Gate-to-Source Forward Leakage Gate-to-Source Reverse Leakage Total Gate Charge Gate-to-Drain ("Miller") Charge Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Internal Drain Inductance Internal Source Inductance Utput Capacitance Output Capacitance	Drain-to-Source Breakdown Voltage -100 Breakdown Voltage Temp. Coefficient Static Drain-to-Source On-Resistance Gate Threshold Voltage -2.0 Forward Transconductance 1.4 Drain-to-Source Leakage Current Gate-to-Source Forward Leakage Gate-to-Source Reverse Leakage Total Gate Charge Gate-to-Drain ("Miller") Charge Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Internal Drain Inductance Input Capacitance Output Capacitance	Drain-to-Source Breakdown Voltage -100 — Breakdown Voltage Temp. Coefficient — -0.11 Static Drain-to-Source On-Resistance — — Gate Threshold Voltage — -2.0 — Forward Transconductance — 1.4 — Drain-to-Source Leakage Current — — Gate-to-Source Forward Leakage — — — Gate-to-Source Reverse Leakage — — — Gate-to-Source Charge — — Gate-to-Drain ("Miller") Charge — — Turn-On Delay Time — 14 Rise Time — 47 Turn-Off Delay Time — 28 Fall Time — 31 Internal Drain Inductance — 4.5 Internal Source Inductance — 350 Output Capacitance — 110	Drain-to-Source Breakdown Voltage -100 — — Breakdown Voltage Temp. Coefficient — -0.11 — Static Drain-to-Source On-Resistance — 0.48 Gate Threshold Voltage -2.0 — -4.0 Forward Transconductance 1.4 — — Drain-to-Source Leakage Current — -25 — -25 Gate-to-Source Leakage Current — -25 — -250 Gate-to-Source Forward Leakage — -100 — -25 Gate-to-Source Reverse Leakage — -100 — -100 Total Gate Charge — -5.0 — -5.0 Gate-to-Source Charge — — -5.0 — -5.0 Gate-to-Drain ("Miller") Charge — — 15 — 15 Turn-On Delay Time — 47 — <	Drain-to-Source Breakdown Voltage -100 — — V Breakdown Voltage Temp. Coefficient — -0.11 — V°C Static Drain-to-Source On-Resistance — — 0.48 Ω Gate Threshold Voltage -2.0 — -4.0 V Forward Transconductance 1.4 — — S Drain-to-Source Leakage Current — -25 μA Gate-to-Source Forward Leakage — — -25 μA Gate-to-Source Forward Leakage — — 100 nA Gate-to-Source Reverse Leakage — — 100 nA Total Gate Charge — — 27 nC Gate-to-Source Charge — — 5.0 nC Gate-to-Drain ("Miller") Charge — — 15 Turn-On Delay Time — 47 — Rise Time — 47 — Internal Drain Inductance — 4.5 —

Source-Drain Ratings and Characteristics

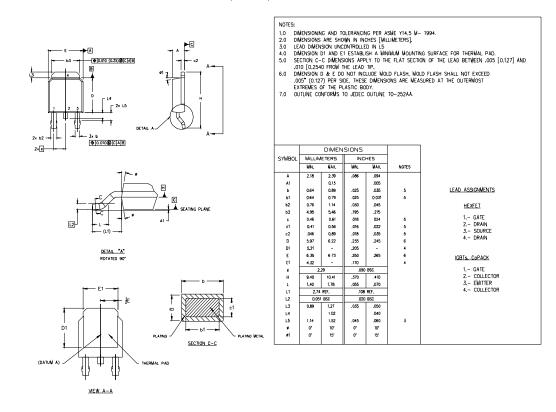
	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current			-6.6		MOSFET symbol	
	(Body Diode)		-0.0	A	showing the		
I _{SM}	Pulsed Source Current			200	-26] /\	integral reverse
	(Body Diode) ①	Diode) ①	26		p-n junction diode.		
V _{SD}	Diode Forward Voltage			-1.6	V	T _J = 25°C, I _S = -3.9A, V _{GS} = 0V ④	
t _{rr}	Reverse Recovery Time		100	150	ns	$T_J = 25$ °C, $I_F = -4.0A$	
Q _{rr}	Reverse Recovery Charge		420	630	nC	di/dt = 100A/µs ④ ⑤	
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)					

Notes:

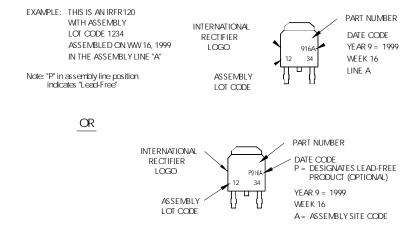
- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting T_J = 25°C, L = 13mH R_G = 25 Ω , I_{AS} = -3.9A. (See Figure 12)
- ③ I $_{SD} \le$ -4.0A, di/dt \le 300A/ μ s, V $_{DD} \le$ V $_{(BR)DSS}$, T $_{J} \le$ 150°C
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- $\mbox{\fontfamily{\fontfamil}{\fontfamily{\fontfamily{\fontfamily{\fontfamily{\fontfamily{\fontfamily{\fontfamily{\fontfamily{\fontfamily{\fontfamily{\fontfamily{\fontfamily{\fontfamily{\fontfamily{\fontfamily{\fontfamil}{\fontfamily{\fontfamily{\fontfamily{\fontfamily{\fontfamil}{\fontfamily{\fontfamil}{\fontfamil$
- © Uses IRF9520N data and test conditions.
- ** When mounted on 1" square PCB (FR-4 or G-10 Material) . For recommended footprint and soldering techniques refer to application note #AN-994

D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)

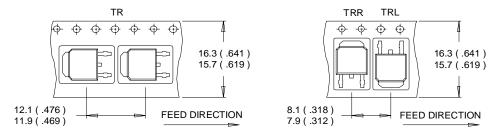


D-Pak (TO-252AA) Part Marking Information

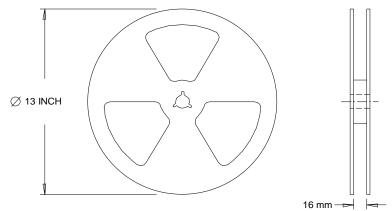


D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



- NOTES:
 1. CONTROLLING DIMENSION: MILLIMETER.
 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.